

PHONONIC BRAGG REFLECTORS FOR THERMAL ISOLATION OF SEMICONDUCTOR QUBITS

SEBASTIAN KOCK

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**The Faculty of Mathematics, Computer Science and Natural Sciences at
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Department of Physics, Institute II C

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supervised by

Prof. Hendrik Bluhm, Ph.D.
Tobias Hangleiter, M.Sc.

ABSTRACT

In recent years, the experimental capability in realizing and exercising full control over multiple coupled quantum dots in semiconductor heterostructures has advanced to the point where tuning the dots to the few-electron regime required for quantum computation applications will become impractical to perform manually, establishing the demand for automated procedures in this area. Moreover, charge stability diagrams, which represent a crucial tool in the tuning of quantum dot systems, become increasingly complex to understand and analyze due to the growing number of parameters influencing their structure. The goal of this thesis is to take a first step towards a fully computer-automated implementation of the tuning process by focusing on the coarse tuning of the system to the zero-electron regime.

I simulate charge diagrams of multiple coupled quantum dots in a linear array using a classical capacitive model, reproducing the honeycomb structure of double quantum dot charge diagrams. In order to automatically recognize the zero-electron regime in double-dot charge diagrams by identifying the charge transitions, I introduce a line detection algorithm using the Radon transform of the charge diagram able to detect lines even in noisy images by exploiting the fact that, in a suitable charge diagram detail, several transitions of the same kind and hence the same slope will show. The strong noise performance of the algorithm promises fast scan times during the tuning process. Finally, I present and test an algorithm that attempts to automatically tune a simulated double-dot system to the zero-electron regime using the line detection algorithm developed.

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the wrong
abstract

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INTRODUCTION

In recent years quantum computing technology has been of rising interest to scientists and the public. The early steps of exploiting the nature of quantum states by fabricating and controlling qubits [refs] are overcome and quantum supremacy, the supremacy of quantum computers over classical computers, is already achieved [ref]. With scalable concepts for many different implementations [refs] it is only a matter of time until quantum computers can be used commercially.

However, there are still a some hurdles to overcome before the technology is at this level. One of them is to reduce the decoherence time, which strongly depends on external conditions like for example, the influence of thermal radiation caused by photons or phonons[refs]. In solid state qubits, heat transfer by phonons is mostly enabled by electronics connected to the chip. These therefore come from a known direction and thus enable the following solution approach. Distributed Bragg reflectors known from optics as layer structures with alternating refraction indices could be used as an intermediate component to reflect the incoming phonons and thus shield the chip.

In optics, this structure is usually used as reflector for light from a defined angle, where it forms spectral regions with high reflectivities. For our purpose, the complete spectrum of thermal radiation needs to be reflected regardless of incident angle in order to stop any incoming phonons. This will be quantified later.

$$J_z = \sum_{i=\{L,TV,TH\}} \int_0^{\omega_c} \int_{\theta,\phi} \mathcal{T}_i(\omega,\theta,\phi) \langle n_B(\omega,T) \rangle \hbar \omega c_i \cos \theta d\omega d\theta d\phi \quad (1.1)$$

1.1 ASSUMPTIONS

Introduction to notation

- notation of vectors and tensors

1.2 OUTLINE

THEORY

In order to understand the complexity of the problem and the utilised solving method, it is reasonable to revisit some fundamental concepts in the following chapter. At the same time, a consistent notation is introduced. At first, the tensor formalism for elastic properties of rigid bodies is introduced. After that, elastic waves are derived and analysed further. This discussion will be mostly based on [1], if not otherwise stated.

justification
for modelling
with elastic
waves

It should be noted in advance, that vectors are denoted by a single underline and tensors or tensor fields of higher order by a number of underlines corresponding to their order. Also, Einstein summation convention should be applied if no explicit summation is given in the same formula.

check if de-
scription still
applies, cita-
tion?

2.1 ELASTIC PROPERTIES OF MATERIALS

In the following, the formalism for bulk elastic properties of materials is introduced. As only small deformations are relevant for the considerations in this thesis, they are assumed to be in the regime of linear elastic behaviour, thus neglecting plastic or nonlinear behaviour.

In one dimension linear elastic behaviour can be described simply by Hooke's law, which states that a small displacement Δl caused by a force F is proportional to the force. Considering an object of length l and cross-sectional area A , **stress** and **strain** can be defined as

$$\text{Stress} \quad \sigma := \frac{F}{A} \quad \text{Strain} \quad \epsilon := \frac{\Delta l}{l} \quad (2.1)$$

Hooke's law can now be reformulated as

$$\sigma = C \epsilon \quad (2.2)$$

with **Young's Modulus C** as proportional constant.

2.1.1 Stress Tensor

For objects of finite size, stress can be defined locally on infinitesimal, cubic volume elements. These volume elements get deformed by forces that are applied to the object. If we consider a general force $\Delta \underline{F}$ acting on a surface element ΔA we can always divide this force into a normal component $\Delta \underline{F}_n$ and two mutually perpendicular tangential components $\Delta \underline{F}_{t1}$ and $\Delta \underline{F}_{t2}$. This implies the general definition of the stress tensor as

$$\sigma_{ij} = \frac{\text{force in direction } i}{\text{surface with normal in direction } j} \quad (2.3)$$

picture of stress definition?

where indices i and j denote one of the spatial directions x, y or z . If we assume the volume element to be in equilibrium, it follows that the normal forces on opposite sites and tangential forces on neighbouring sides equal each other. The latter implies that $\sigma_{ij} = \sigma_{ji}$. This leaves 6 independent components, the three normal stresses σ_{ii} and the three shear stresses σ_{ij} .

2.1.2 Strain Tensor

check definitions

Deformation of a three-dimensional object can be described using the displacement field $\underline{u}(\underline{r}, t) := \underline{r}' - \underline{r}$, which defines a displacement vector for each point \underline{r} in space in comparison to the deformed position \underline{r}' . Local stress only relates to change in displacement relative to neighbouring positions which allows to consider the Taylor expansion in first order

$$\underline{u}(\underline{r} + \Delta \underline{r}, t) = \underline{u}(\underline{r}, t) + \underline{\nabla} \underline{u}(\underline{r}, t) \Delta \underline{r} \quad (2.4)$$

with the Jacobian matrix $(\underline{\nabla} \underline{u})_{ij} = \frac{\partial u_i}{\partial r_j}$. This in turn can be decomposed into a symmetric part and an antisymmetric part. The symmetric part is defined as strain tensor:

$$\epsilon_{ij} = \frac{1}{2} \left(\frac{\partial u_i}{\partial r_j} + \frac{\partial u_j}{\partial r_i} \right) \quad (2.5)$$

why is rotation irrelevant?

It is a dimensionless measure for local deformation in contrast to the antisymmetric part, which represents local rotation.

$$xx \rightarrow 1 \quad yy \rightarrow 2 \quad zz \rightarrow 3 \quad yz = zy \rightarrow 4 \quad xz = zx \rightarrow 5 \quad xy = yx \rightarrow 6$$

Table 2.1: Voigt notation

2.1.3 Stress-Strain Relations

Having introduced the stress and the strain tensors, equation 2.2 can be generalised to three dimensions, thereby taking anisotropies of the material into account:

$$\sigma_{ij} = C_{ijkl} \epsilon_{kl} \quad \text{or} \quad \underline{\underline{\sigma}} = \underline{\underline{C}} \cdot \underline{\underline{\epsilon}} \quad (2.6)$$

This defines the **Elasticity tensor** as order 4 tensor with unit force / area. In general this tensor contains 81 components. However, both the stress

and the strain tensor are symmetric, so that $C_{ijkl} = C_{jikl} = C_{ijlk}$. This reduces the number of independent components to 36 and makes it possible to describe the Elasticity tensor as a 6×6 matrix. For this representation, the so called Voigt notation maps pairs of coefficients of elasticity, strain and stress tensor to a single index as in table 2.1 This simplifies the notation of elasticity significantly, but it should be treated carefully. Tensors written in Voigt notation do not transform like vectors in each index.

One can also prove, that $C_{ijkl} = C_{klij}$ considering elastic energy (see section 4.3.1 of [1]) which leads to 21 independent components. Further simplifications derive from crystal symmetry or limitations in anisotropy. In the following treatment, the material is assumed to be isotropic, which reduces the number of independent components to 2. These are typically introduced as Lamé constants λ and μ defined by the relation

$$\sigma_{ij} = \lambda \delta_{ij} \epsilon_{kk} + 2\mu \epsilon_{ij} \quad (2.7)$$

which derives from equation 2.6 by regarding isotropy of the material [2]. From this equation the elasticity tensor can be expressed by a simplified 6×6 matrix as in:

$$\underline{\underline{\sigma}} = \underline{\underline{C}} \cdot \underline{\underline{\epsilon}} = \begin{pmatrix} \lambda + 2\mu & \lambda & \lambda & 0 & 0 & 0 \\ \lambda & \lambda + 2\mu & \lambda & 0 & 0 & 0 \\ \lambda & \lambda & \lambda + 2\mu & 0 & 0 & 0 \\ 0 & 0 & 0 & 2\mu & 0 & 0 \\ 0 & 0 & 0 & 0 & 2\mu & 0 \\ 0 & 0 & 0 & 0 & 0 & 2\mu \end{pmatrix} \cdot \begin{pmatrix} \epsilon_1 \\ \epsilon_2 \\ \epsilon_3 \\ \epsilon_4 \\ \epsilon_5 \\ \epsilon_6 \end{pmatrix} \quad (2.8)$$

what is the usual convention?

mention of einstein convention?

2.2 ELASTIC WAVES

This formalism can now be used to introduce elastic waves. Their existence and behaviour depends on the equations of motion of the regarded medium. To obtain these, we consider at first a small volume $\Delta V = \Delta x \Delta y \Delta z$ that is subject to a stress $\sigma_{xx}(x)$ on the one side and to $\sigma_{xx}(x + \Delta x)$ on the other side. The resulting net force becomes thus

$$\Delta F_x = [\sigma_{xx}(x + \Delta x) - \sigma_{xx}(x)] \Delta z \Delta y = \frac{\partial \sigma_{xx}}{\partial x} \Delta x \Delta y \Delta z \quad (2.9)$$

by approximating $\sigma_{xx}(x + \Delta x)$ in first order and setting the frame of reference to the center of mass of the volume. The force leads to a displacement u_x of the volume in x direction and equals the product of the mass $\rho \Delta x \Delta y \Delta z$ and acceleration in x direction $\frac{\partial^2 u_x}{\partial t^2}$. This yields the one dimensional partial differential equation

$$\rho \frac{\partial^2 u_x}{\partial t^2} = \frac{\partial \sigma_{xx}}{\partial x} \quad (2.10)$$

Assuming an isotropic material and using relation 2.6 we get

$$\rho \frac{\partial^2 u_x}{\partial t^2} = C_{11} \frac{\partial \epsilon_{xx}}{\partial x} = C_{11} \frac{\partial^2 u_x}{\partial x^2} \quad (2.11)$$

In an anisotropic medium the other stress components need to be taken into account leading to the general wave equation

$$\rho \frac{\partial^2 u_i}{\partial t^2} = \frac{\partial \sigma_{ij}}{\partial x_j} = C_{ijkl} \frac{\partial^2 u_l}{\partial x_j \partial x_k} \quad (2.12)$$

2.2.1 Solution for Isotropic Materials

In the following analysis, only isotropic media will be considered. In this case the isotropic stress-strain relation, equation 2.8, can be inserted in the wave equation which yields

$$\rho \frac{\partial^2 \underline{u}}{\partial t^2} = (\lambda + \mu) \underline{\nabla}(\underline{\nabla} \cdot \underline{u}) + \mu \underline{\nabla}^2 \underline{u} \quad (2.13)$$

By using the relation $\underline{\nabla}^2 \underline{u} = \underline{\nabla}(\underline{\nabla} \cdot \underline{u}) - \underline{\nabla} \times (\underline{\nabla} \times \underline{u})$ for the vector Laplace operator one can express it as

$$\rho \frac{\partial^2 \underline{u}}{\partial t^2} = (\lambda + 2\mu) \underline{\nabla}(\underline{\nabla} \cdot \underline{u}) - \mu \underline{\nabla} \times (\underline{\nabla} \times \underline{u}) \quad (2.14)$$

If we now consider the Helmholtz decomposition of the displacement fields

$$\underline{u} = \underline{\nabla}\Phi + \underline{\nabla} \times \underline{\Psi} \quad (2.15)$$

with elastic potentials Φ and Ψ and insert it into 2.14, it decouples to the two equations (see [3])

$$\frac{\partial^2 \Phi}{\partial t^2} = c_L^2 \underline{\nabla}^2 \Phi \quad (2.16)$$

$$\frac{\partial^2 \underline{\Psi}}{\partial t^2} = c_T^2 \underline{\nabla}^2 \underline{\Psi} \quad (2.17)$$

$$\text{with } c_L = \left(\frac{\lambda + 2\mu}{\rho} \right)^{1/2} \quad \text{and} \quad c_T = \left(\frac{\mu}{\rho} \right)^{1/2} \quad (2.18)$$

Those equations represent four wave equations for the elastic potentials with phase velocities c_L and c_T .

In analogy to electromagnetic waves we can now make the harmonic plane wave ansatz $\Phi(\underline{x}, t) = u_L e^{i(\underline{k}_L \underline{x} - \omega t)}$ and $\underline{\Psi}(\underline{x}, t) = \underline{u}_T e^{i(\underline{k}_T \underline{x} - \omega t)}$ with arbitrary amplitudes $u_L \in \mathbb{C}$ and $\underline{u}_T \in \mathbb{C}^3$. Here, the vector $\underline{k} = \frac{2\pi}{\lambda}$ denotes the wave vector defined by the wavelength λ and ω is the circular frequency defined by the oscillation frequency f with $\omega = 2\pi f$. The differentiation between \underline{k}_L and \underline{k}_T is necessary because of the different phase velocities for the elastic potentials resulting in different wave numbers according to $c = \frac{\omega}{|\underline{k}|}$.

Substituting the wave ansätze into equation 2.15, we get

$$\underline{u} = u_L \underline{k} e^{i(\underline{k}_L \underline{x} - \omega t)} + \underline{k} \times \underline{u}_T e^{i(\underline{k}_T \underline{x} - \omega t)} \quad (2.19)$$

Here we can see now, that the elastic potential Φ is responsible for waves with longitudinal polarisation and $\underline{\Psi}$ for waves with transversal propagation. Furthermore we can identify an orthonormal polarisation basis depending on the propagation direction $\hat{\underline{k}} = \frac{\underline{k}}{|\underline{k}|}$ so that \underline{u} decomposes to

$$\underline{u} = a_L \underline{p}_L e^{i(\underline{k}_L \underline{x} - \omega t)} + (a_{TH} \underline{p}_{TH} + a_{TV} \underline{p}_{TV}) e^{i(\underline{k}_T \underline{x} - \omega t)} \quad (2.20)$$

In general, the polarisation vector for longitudinal polarisation \underline{p}_L is fixed to be $\hat{\underline{k}}$. If scattering at an interface is considered, a plane of incidence can be defined that is spanned by $\hat{\underline{k}}$ and the normal vector of the interface. The transversal polarisation vectors are then defined as transversal horizontal polarisation \underline{p}_{TH} pointing out of the plane of incidence and transversal vertical polarisation \underline{p}_{TV} lying in plane of incidence orthonormal to $\hat{\underline{k}}$, here now defined as $\underline{p}_{TV} = \underline{p}_L \times \underline{p}_{TH}$.

decomposition:
e.g
 $a_L = \underline{u}(\underline{x}, t) \cdot \hat{\underline{k}} * e^{-i\hat{\underline{k}}\underline{x} + i\omega t}$
?

sketch

To sum up, those polarisation vectors define three polarisation modes L, TH and TV denoting longitudinal, transversal horizontal and transversal vertical polarisation which can be superimposed arbitrarily. The coefficients a_i may be complex to express an additional phase between the components. However, it should be noted, that this is merely convenient for calculation and that the physical wave behaves like the real part of the shown equations.

2.2.2 Elastic Wave Scattering at an Interface

Boundary Conditions

On the way to describe wave propagation through complex layer structures it is useful to consider a single interface first. In the upper half space S_1 and lower half space S_2 we assume homogeneous materials with different elastic constants and thus different sound velocities. At the interface, which is chosen to be the xy-plane the elastic properties are discontinuous. However, we can assume that those layers connected strongly so that the displacement field and normal stresses are continuous at the boundary [4, pp. 182, 185]. This leads to the boundary conditions:

$$\underline{u}^{(1)}(\underline{r}, t)|_{\underline{r} \in \partial S_1} = \underline{u}^{(2)}(\underline{r}, t)|_{\underline{r} \in \partial S_2} \quad (2.21)$$

$$\sigma_{13}^{(1)}(\underline{r}, t)|_{\underline{r} \in \partial S_1} = \sigma_{13}^{(2)}(\underline{r}, t)|_{\underline{r} \in \partial S_2} \quad (2.22)$$

$$\sigma_{23}^{(1)}(\underline{r}, t)|_{\underline{r} \in \partial S_1} = \sigma_{23}^{(2)}(\underline{r}, t)|_{\underline{r} \in \partial S_2} \quad (2.23)$$

$$\sigma_{33}^{(1)}(\underline{r}, t)|_{\underline{r} \in \partial S_1} = \sigma_{33}^{(2)}(\underline{r}, t)|_{\underline{r} \in \partial S_2} \quad (2.24)$$

In these six equations displacement and stress from upper and lower medium are differentiated by the given superscript index.

Law of Refraction

If we now consider a plane wave that is incident on that interface, we can define a plane of incidence as in section 2.2.1 and rotate the coordinate system so that it equals the yz-plane which simplifies the polarisation basis. This leaves the physical problem only invariant, if we assume an isotropic material as stated before. In that setting, the wave vector \underline{k}_i for a particular mode $i \in \{L, TV, TH\}$ can be parametrised by the angle of incidence θ as

$$\underline{k}_i = \frac{\omega}{c_i} (0, \sin(\theta_i), -\cos(\theta_i))^T \quad (2.25)$$

introduced in
2.2.1

consistent
mode descrip-
tion

The polarisation basis can then be defined as

$$\underline{p}_L = \hat{k} = (0, \sin(\theta_i), -\cos(\theta_i))^T \quad (2.26)$$

$$\underline{p}_{TH} = (1, 0, 0)^T \quad (2.27)$$

$$\underline{p}_{TV} = \underline{p}_L \times \underline{p}_{TH} = (0, -\cos(\theta), -\sin(\theta))^T \quad (2.28)$$

It is now possible to extract a law of refraction from the boundary conditions in equation 2.21 (see [4, 168ff]). A simple approach is to consider scattering of the transversal horizontal mode (TH) so that the displacement is only in x-direction. An incoming plane wave with wave vector \underline{k}_{in} is partially reflected to a wave along \underline{k}_r and partially transmitted through the interface to a wave with \underline{k}_t . Also, different frequencies ω_i are assumed for the scattered waves so that the wave in the upper medium is

$$u_1^{(1)} = a_{in} e^{i(k_{in} \sin \theta_{in} y - \omega_{in} t)} + a_r e^{i(k_r (\sin \theta_r y - \omega_r t))} \quad (2.29)$$

and in the lower medium

$$u_1^{(2)} = a_t e^{i(k_t \sin \theta_t y - \omega_t t)} \quad (2.30)$$

Here it was used, that the interface is at $z = 0$ which simplifies the following derivation. According to the boundary conditions, these displacements must equal each other at any time and for all points on the interface. This leads to the immediate conclusion, that

$$\omega = \omega_{in} = \omega_r = \omega_t \quad (2.31)$$

After removing the common factor $e^{-i\omega t}$ from the equation and expressing the wave numbers by frequency and sound velocity as $k = \frac{\omega}{c}$, we get

$$a_{in} e^{i \frac{\omega}{c_{T,1}} \sin \theta_{in} y} + a_r e^{i \frac{\omega}{c_{T,1}} \sin \theta_r y} = a_t e^{i \frac{\omega}{c_{T,2}} \sin \theta_t y} \quad (2.32)$$

This however can be only fulfilled for all $y \in \mathbb{R}$ if the relations

$$a_{in} + a_r = a_t \quad (2.33)$$

$$\frac{\sin \theta_{in}}{c_{T,1}} = \frac{\sin \theta_r}{c_{T,1}} = \frac{\sin \theta_t}{c_{T,2}} \quad (2.34)$$

are met. Equation 2.34 can be also interpreted as the equality of the wave vector component parallel to the interface $k_y = \sin \theta_i \frac{\omega}{c_i}$.

The same procedure can be applied to the y and z component of the displacement field, where transversal vertical (TV) and longitudinal (L) modes need to be considered [4, p. 185]. However, one significant difference is that even for a

single incident mode, both L and TV mode are possible after being reflected or transmitted. This will only add a term of the form $a_i e^{i\frac{\omega}{c} \sin\theta_i y}$ to each side of equation 2.32, but will result in analogous relations to 2.31 and 2.34, namely the invariance of frequency ω and k_2 of each mode under scattering at the interface.

To conclude, the angle θ_{out} of any outgoing polarisation mode can be determined from the incoming wave's angle θ_{in} and the sound velocities for incoming and outgoing wave c_{in}, c_{out} by

$$\frac{\sin\theta_{in}}{c_{in}} = \frac{\sin\theta_{out}}{c_{out}} \quad (2.35)$$

This can be transferred to the optical law of snellius by introducing an effective refraction index $n_i = \frac{1}{c_i}$. Consequently, TH-polarised waves scatter like electromagnetic waves and for example the reflected angle is always the incident angle. The main difference to optics becomes clear for L and TV polarised waves. Scattering within the same polarisation mode is the same as for the TH mode, but now those modes can scatter into each other. Equation 2.35 still applies, but energy is also emitted to additional modes as shown in figure 2.1.

It is also possible to get the analytical solutions for refraction of a single mode at an interface by evaluating the remaining boundary conditions and the results from continuity of displacement. The results are usually expressed by defining a reflection coefficient r_i and a transmission coefficient t_i for participating mode $i \in \{L, TH, TV\}$ as

$$r_i := \frac{a_{r,i}}{a_{in,i}} \quad (2.36)$$

$$t_i := \frac{a_{t,i}}{a_{in,i}} \quad (2.37)$$

Usually those coefficients have a functional dependency on the incident angle.

Total Internal Reflection

Total internal reflection is known as the phenomenon when a wave is totally reflected at a boundary for incident angles greater than a critical angle θ_{tot} . If c_1 and c_2 are the phase velocities first and second medium, the outgoing angle

$$\theta_2 = \arcsin\left(\frac{c_1}{c_2} \sin(\theta_1)\right) \quad c_2 < c_1 \quad (2.38)$$

has no real solution for $\theta_1 > \theta_{tot} = \arcsin \frac{c_2}{c_1}$. There is however a complex solution and this resulting complex angle can be interpreted in the given wave formalism [5, p. 5]. This interpretation also allows to extend the concept to two arbitrary

polarisation modes that the wave can scatter inbetween, regardless of propagation direction.

Considering the case $\theta_1 > \theta_{tot}$, θ_2 can be expressed as $\theta_2 = \frac{\pi}{2} + i\alpha$, $\alpha \in \mathbb{R}$. Inserting this into the general wave solution equation 2.20, we need to calculate the wave vector \underline{k} as in equation 2.25. This results in

$$k_y = k \sin \theta_2 = k \cosh \alpha \quad k_z = k \cos \theta = ik \sinh \alpha \quad (2.39)$$

This complex wave vector inserted into the factor $e^{ik_z z}$ results in $e^{-k \sinh \alpha z}$ which represents an evanescent wave. This type of wave is attenuated exponentially so that the wave behaves as expected.

In case of frustrated total internal reflection this exponential behaviour becomes relevant, when another interface is close to the first reflecting interface. Then it is possible for the usually totally reflected mode to transmit intensity into a mode of the third medium.

Conservation of Energy at a Single Interface

According to [4, p. 166] the transmitted time averaged power per unit area of a transversal elastic wave in a homogeneous medium is

$$I_L = \frac{1}{2}(\lambda + 2\mu)\frac{\omega^2}{c_L}|a_L|^2 \quad (2.40)$$

and similarly for a transversal elastic wave of a single polarisation mode

$$I_T = \frac{1}{2}\mu\frac{\omega^2}{c_T}|a_T|^2 \quad (2.41)$$

where a_T is either a_{TV} or a_{TH} depending on the regarded mode. This quantity is also known as time averaged intensity. By using the definition of c_L and c_T from equation 2.18 we get the more general relation

$$I_p = \frac{\rho\omega^2}{2}|a_p|^2 c_p \quad (2.42)$$

with $p \in \{L, TH, TV\}$ denoting the polarisation mode. It should be noted that the referred unit area is perpendicular to the direction of propagation.

In the setting of an arbitrary polarised wave scattered at an interface, there are six possible outgoing modes as discussed previously. To get an energy relation between the intensities of each participating mode we consider the energy balance of a surface element ΔS of the interface, on which an arbitrarily polarised beam

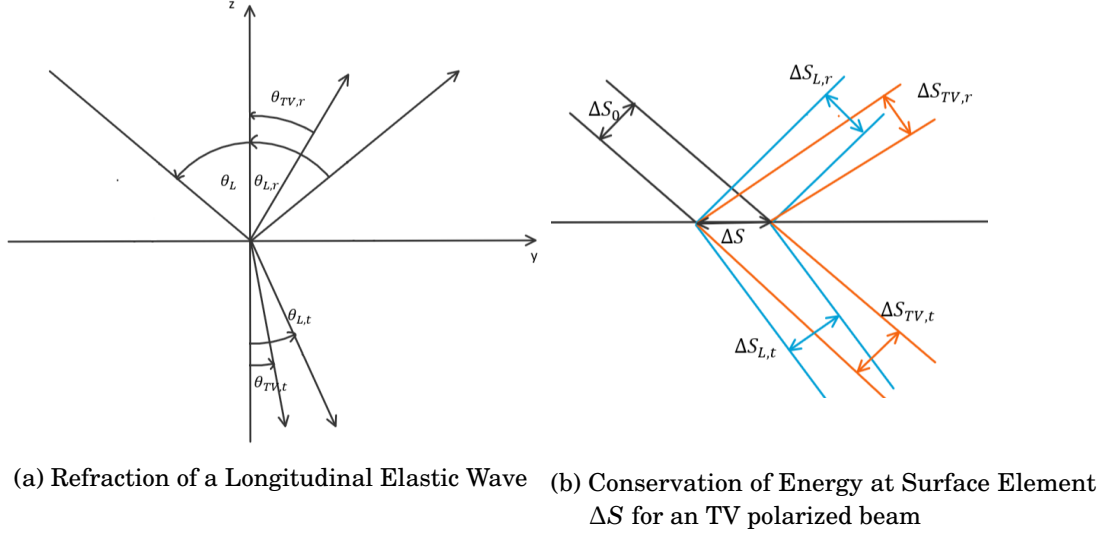


Figure 2.1

with cross-sectional area ΔS_0 and intensity I_{in} is incident. The cross-sectional areas of the outgoing beams are named according to figure 2.1b which can be also transferred to the case of an incident TH polarised wave.

The power each beam transmits or emits is given by the product $P_p = I_p \Delta S_p$. ΔS_p is related to ΔS by $\Delta S_p = \cos \theta_p \Delta S$, p denoting any of the depicted beams and θ_p being the according angle.

In conclusion, the energy balance results in

$$I_{in} \cos \theta_{in} = \sum_{i=L,TH,TV} I_{i,r} \cos \theta_{i,r} + I_{i,t} \cos \theta_{i,t} \quad (2.43)$$

From that we can divide by $I_{in} \cos \theta_{in}$ and define reflectivity \mathcal{R} and transmittivity \mathcal{T} of the interface as fraction of reflected and transmitted power by

$$\mathcal{R} := \frac{I_{L,r} \cos \theta_{L,r} + I_{TH,r} \cos \theta_{T,r} + I_{TV,r} \cos \theta_{T,r}}{I_{in} \cos \theta_{in}} \quad (2.44)$$

$$\mathcal{T} := \frac{I_{L,t} \cos \theta_{L,t} + I_{TH,t} \cos \theta_{T,t} + I_{TV,t} \cos \theta_{T,t}}{I_{in} \cos \theta_{in}} \quad (2.45)$$

so that $\mathcal{R} + \mathcal{T} = 1$ is fulfilled. This can be later used to verify the obtained results.

2.2.3 Scattering at a System of Layers

The considerations of one interface can now be extended to a system of N interfaces as shown in figure 2.2. Each layer gets an index n starting from the uppermost

layer of index $n = 0$. The first interface from the top is still located at $z_1 = 0$ and has index $n = 1$. The subsequent interfaces follow below at depths z_n . Their depth depends on the intermediate layer thicknesses $d_n = z_n - z_{n+1}$ with layer index n . Similar as before, we assume now the displacement field in each layer n as

$$\underline{u}^{(n)}(\underline{x}, t) = \sum_{i \in \{L, TH, TV\}} t_{n,i} \underline{p}_{-n,i}^t e^{i(\underline{k}_{n,i}^t \underline{x} - \omega t)} + r_{n,i} \underline{p}_{-n,i}^r e^{i(\underline{k}_{n,i}^r \underline{x} - \omega t)} \quad (2.46)$$

This formula is a superposition of a down going wave with quantities denoted by t and an upgoing wave caused by reflections with quantities denoted by r . The upgoing \underline{k}^r is flipped in z -direction compared to \underline{k}^t . Further, the complex amplitudes of down and upgoing modes are directly denoted by $t_{n,i}$ and $r_{n,i}$. As the angle $\theta_{n,i}$ between \underline{k} and z -axis is changes by scattering, also $\underline{k}_{n,i}$ and polarisation vector $\underline{p}_{-n,i}$ is different for each material.

To evaluate the transmission through the stack of layers, it is the task is now to calculate the coefficients $t_{N,i}$ and $r_{1,i}$ given coefficients $t_{1,i}$ and with the assumption $r_{N,i} = 0$ for all $i \in \{L, TH, TV\}$. This assumption can be made because we only consider the incoming power on the chip. Thermal radiation from the chip itself is significantly lower. We further choose exactly one $t_{1,i} = 1$ to mark the incident mode. This simplifies solving the problem and lets the coefficients $t_{N,i}$ and $r_{1,i}$ become the transmission and reflection coefficients of the layer system.

correct explanation?

For this, all $6N$ boundary conditions need to be solved. These are constructed by inserting the general displacement field of each participating layer as in equation 2.46 in the boundary conditions for a single interface (equation 2.21). As a result each displacement field of an enclosed layer is evaluated twice, once at the upper boundary and once at the lower boundary. This results in a phase shift of $e^{-ik_z d_n}$ between upper and lower displacement.

As many systems of equations this problem can be formulated with matrices. In the following, two solution methods are introduced. In the later course, both methods will be compared to each other on the base of practical advantages and disadvantages.

Transfer Matrix Method

To introduce the matrix formalism of the Transfer Matrix Method (TMM) it is useful to focus on a single interface with index n between layers $n - 1$ and n located at depth z_n . We can define a generalised state vector \underline{v}_i in each layer i as [6]

$$\underline{v}_i = (u_1^{(i)}, u_2^{(i)}, u_3^{(i)}, \sigma_{13}^{(i)}, \sigma_{23}^{(i)}, \sigma_{33}^{(i)})^T \quad (2.47)$$

Each of the components depends on location \underline{x} and time t in the layer. We also introduce the superscript "+" for evaluating an arbitrary multidimensional function

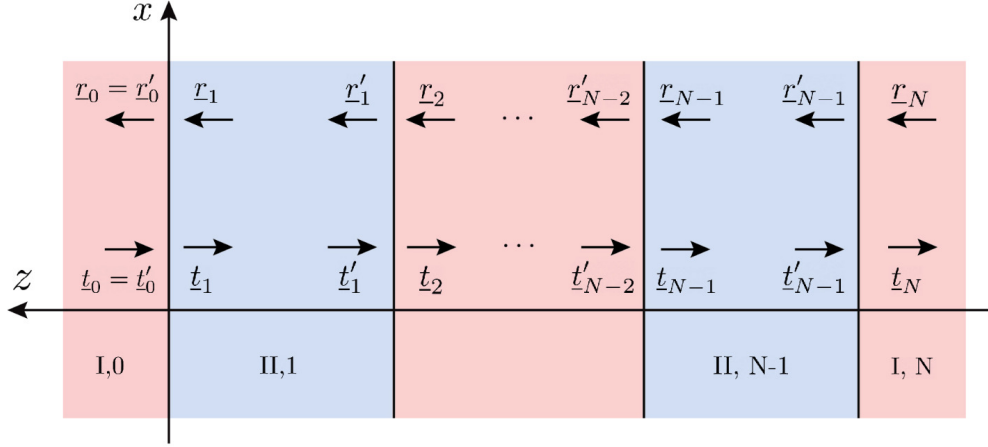


Figure 2.2: Geometry and amplitude nomenclature of a N layer strong bragg reflector

of space and layer index n at interface \mathcal{F}_n and superscript "-" for evaluating at \mathcal{F}_{n-1} so that the boundary conditions at the n -th interface \mathcal{F}_n are

$$\underline{v}_n^+ = \underline{v}_{n+1}^- \quad (2.48)$$

In addition to equation 2.46, the stress components in \underline{v} can be evaluated as well. From stress strain relation 2.6 we get for an isotropic material

$$C_{1313}^{(n)} \epsilon_{13}^{(n),+} = C_{1313}^{(n+1)} \epsilon_{13}^{(n+1),-} \quad (2.49)$$

$$C_{2323}^{(n)} \epsilon_{23}^{(n),+} = C_{2323}^{(n+1)} \epsilon_{23}^{(n+1),-} \quad (2.50)$$

$$\sum_{i=1}^3 C_{33ii}^{(n)} \epsilon_{ii}^{(n),+} = \sum_{i=1}^3 C_{33ii}^{(n+1)} \epsilon_{ii}^{(n+1),+} \quad (2.51)$$

Furthermore, the strain can be evaluated by inserting the general displacement field 2.46 into its definition $\epsilon_{ij} = \frac{1}{2} \left(\frac{\partial u_i}{\partial r_j} + \frac{\partial u_j}{\partial r_i} \right)$.

At this point it is necessary to know all angles at which the different modes propagate through each layer in order to construct the equations as linear relations. These can be obtained by following the considerations of section 2.2.2. Because of our limitation to one incident mode on the top layer, also only one propagation angle per distinct phase velocity in the medium is possible. From the structure of $\underline{u}^{(n)}$ it is possible to construct a 6×6 matrix \underline{M}_n so that

$$\underline{v}_n(z) = \underline{\underline{M}}_n \underline{\underline{P}}_n(z - z_n) \underline{a}_n \quad (2.52)$$

The coefficient vector \underline{a}_n of layer n is defined as

$$\underline{a}_n = (\underline{t}_n, \underline{r}_n)^T = (t_{n,L}, t_{n,TH}, t_{n,TV}, r_{n,L}, r_{n,TH}, r_{n,TV})^T \quad (2.53)$$

mention, that propagation of angles is needed first

containing the wave amplitudes at the upper edge of each layer $z = z_n$. As an exception, $r_{0,i}$ and $t_{0,i}$ are defined directly at the first interface.

$\underline{\underline{P}}_n(z)$ represents the phase factors due to wave propagation as diagonal matrix

$$\underline{\underline{P}}_n(z) = \text{diag}\{e^{ik_{z,n}^{(L)}z}, e^{ik_{z,n}^{(TH)}z}, e^{ik_{z,n}^{(TV)}z}, e^{-ik_{z,n}^{(L)}z}, e^{-ik_{z,n}^{(TH)}z}, e^{-ik_{z,n}^{(TV)}z}\} \quad (2.54)$$

The factor $e^{k_{y,n}^{(i)}y}$ was removed from the expression as it does not change at the boundary. This automatically sets the phase of the displacement wave to zero at the upper boundary of the layer. The coefficients at the lower boundary are in the following denoted by $\underline{a}'_n = \underline{\underline{P}}_n(-d_n) \underline{a}_n$.

clear?

As a result the boundary conditions at an individual interface between layers $n-1$ and n can be written as

$$\underline{\underline{M}}_{n-1} \underline{a}'_{n-1} = \underline{\underline{M}}_n \underline{a}_n \quad (2.55)$$

If we assume that $\underline{\underline{M}}_n$ is invertible, we can define the transfer matrix S_n by

$$\underline{a}_n = \underline{\underline{M}}_n^{-1} \underline{\underline{M}}_{n-1} \underline{a}'_{n-1} = \underline{S}_n \underline{a}'_n \quad (2.56)$$

which enables us to obtain the wave coefficients after scattering by a simple matrix multiplication.

With this knowledge we can assemble a global transfer matrix for all interfaces by

$$\underline{\underline{S}} = \underline{\underline{S}}_N \cdot \underline{\underline{P}}_{\underline{\underline{N}}}(z_N - z_{N-1}) \cdot \underline{\underline{S}}_{\underline{\underline{N-1}}} \cdot \underline{\underline{P}}_{\underline{\underline{N-1}}}(z_{N-1} - z_{N-2}) \cdots \underline{\underline{S}}_2 \cdot \underline{\underline{P}}_{\underline{\underline{2}}}(z_2 - z_1) \cdot \underline{\underline{S}}_1 \quad (2.57)$$

so that the final wave coefficients \underline{a}_N below the lowest interface are

$$\begin{pmatrix} \underline{t}_n \\ \underline{r}_n \end{pmatrix} = \underline{S} \cdot \begin{pmatrix} \underline{t}_1 \\ \underline{r}_1 \end{pmatrix} = \begin{pmatrix} \underline{T} & \underline{C} \\ \underline{C} & \underline{R} \end{pmatrix} \cdot \begin{pmatrix} \underline{t}_1 \\ \underline{r}_1 \end{pmatrix} \quad (2.58)$$

Remembering that $\underline{r}_n = 0$, we can solve for \underline{r}_1 and \underline{t}_n

$$\underline{r}_1 = -\underline{R}^{-1} \underline{C} \underline{t}_1 \quad (2.59)$$

$$\underline{t}_n = \begin{pmatrix} \underline{T} & \underline{C} \\ \underline{C} & \underline{R} \end{pmatrix} \cdot \begin{pmatrix} \underline{t}_1 \\ -\underline{R}^{-1} \underline{C} \underline{t}_1 \end{pmatrix} \quad (2.60)$$

Linear System of Equations

As an alternative, a more direct solving approach is presented by solving the system of linear equations with the inversion of a single matrix. This method will be called from now on LSE-method (Linear System of Equations).

For this method the coefficients for upgoing waves are defined to have their phase origin at the lower interface instead of the upper interface as defined in 2.54, so that the P-matrix becomes

$$\underline{\underline{P}}_n(z) = \text{diag}\{e^{ik_{z,n}^{(L)}z}, e^{ik_{z,n}^{(TH)}z}, e^{ik_{z,n}^{(TV)}z}, e^{-ik_{z,n}^{(L)}(z+d_n)}, e^{-ik_{z,n}^{(TH)}(z+d_n)}, e^{-ik_{z,n}^{(TV)}(z+d_n)}\} \quad (2.61)$$

. The reason is that the diagonal entries evaluated at the layer boundaries $z = 0$ and $z = -d_n$ will now have always absolute values of 1 or lower. The latter is true for total internal reflection in contrary to $\underline{\underline{P}}_n$ from TMM.

For better clarity in notation we can rewrite matrix $\underline{\underline{M}}_n$ as composition of two 6×3 matrices $\underline{\underline{M}}_n = (\underline{\underline{T}}_n, \underline{\underline{R}}_n)$ and $\underline{\underline{P}}_n$ as block diagonal of two 3×3 matrices $\underline{\underline{P}}_n = \text{diag}\{\underline{\underline{D}}_n(z), \underline{\underline{D}}_n(-(z+d_n))\}$. The diagonal matrix $\underline{\underline{D}}_n$ is here defined as a 3×3 diagonal matrix with $\underline{\underline{D}}_n(z) = \text{diag}\{e^{ik_{z,n}^{(L)}z}, e^{ik_{z,n}^{(TH)}z}, e^{ik_{z,n}^{(TV)}z}\}$

The boundary conditions at interface n , below layer n are then

$$\left(\underline{\underline{T}}_n, \underline{\underline{R}}_n \cdot \underline{\underline{D}}_n(-d_n)\right) \begin{pmatrix} t_n \\ r_n \end{pmatrix} = \left(\underline{\underline{T}}_{n-1} \cdot \underline{\underline{D}}_{n-1}(-d_{n-1}), \underline{\underline{R}}_{n-1}\right) \begin{pmatrix} t_{n-1} \\ r_{n-1} \end{pmatrix} \quad (2.62)$$

With $\underline{\underline{T}}'_{n-1} = \underline{\underline{T}}_{n-1} \cdot \underline{\underline{D}}_{n-1}(-d_{n-1})$ and analogously for $\underline{\underline{R}}'_n$, this is equivalent to

$$\left(\underline{\underline{T}}'_{n-1}, \underline{\underline{R}}_{n-1} - \underline{\underline{T}}_n, -\underline{\underline{R}}'_n\right) \begin{pmatrix} t_{n-1} \\ r_{n-1} \\ t_n \\ r_n \end{pmatrix} = 0 \quad (2.63)$$

This denotes now a 6×12 matrix for a single interface. In general the total system is constructed as $6N \times 6N$ matrix

$$\begin{pmatrix} \underline{\underline{R}}_0 & -\underline{\underline{T}}_1 & -\underline{\underline{R}}'_1 & 0 & 0 & \cdots & 0 \\ 0 & \underline{\underline{T}}'_1 & \underline{\underline{R}}_1 & -\underline{\underline{T}}_2 & -\underline{\underline{R}}'_2 & \cdots & \vdots \\ \vdots & \ddots & \ddots & \ddots & \ddots & \ddots & \vdots \\ \vdots & \ddots & \ddots & \ddots & \ddots & \ddots & \vdots \\ 0 & \cdots & \cdots & 0 & \underline{\underline{T}}'_{N-1} & \underline{\underline{R}}_{N-1} & -\underline{\underline{T}}_N \end{pmatrix} \begin{pmatrix} r_0 \\ t_1 \\ r_1 \\ \vdots \\ t_N \end{pmatrix} = \begin{pmatrix} -\underline{\underline{T}}_0 t_0 \\ 0 \\ \vdots \\ \vdots \\ \underline{\underline{R}}_N r_N \end{pmatrix} \quad (2.64)$$

The transfer of $\underline{\underline{T}}_0 t_0$ and $\underline{\underline{R}}_N r_N$ is necessary to ensure quadratic shape of the matrix which is necessary for inversion. However, this limits the number of

interfaces to $N > 1$. By setting $\underline{r}_N = 0$ as before we obtain \underline{r}_0 and \underline{t}_N after inverting the $6N \times 6N$ matrix.

IMPLEMENTATION

On basis of the preceding theory a full simulation of acoustic wave propagation through multilayer structures was developed. This will be described in more detail in the following aiming to provide a short introduction into code structure and functionality. Arisen challenges and their solution will be presented afterwards.

3.1 CODE STRUCTURE AND FUNCTIONALITY

The main components of the project are represented by the three python modules `dbr.py`, `materials.py` and `plotfunctions.py` to organise written methods by purpose.

`materials.py` contains elastic parameters of materials that where considered for usage in a reflector structure. Each entry is a python function that returns density ρ and elastic constants λ and μ . Most databases accessible through the internet contain different elastic constants like Young's Modulus or Poisson's ratio, so that those are converted with help of a formula table as in [2, p. 30]. The exact materials and their sources are listed in table

The file `dbr.py` contains the most important simulation tools. Those functions are structured in two classes, `Reflector` and `Layer` to reduce the number of parameters to be passed to the next method.

The main idea for the `Layer` class, is to wrap the important material parameters λ , μ and ρ passed from a material parameter function and to convert them internally to sound velocities c_i and elastic tensor. In addition, each object stores its thickness and material name. The latter is useful for fast identification of the layer material and debugging outputs. Also, it contains several methods for calculation of Layer specific quantities. One of those quantities is `getConditionMatrix()` which assembles the condition matrix $\underline{\underline{M}}_n$ for given incident angle θ and frequency ω . In the process, the layer specific wave vector \underline{k}_i is calculated by `Layer.getK()` for every mode from incident angle and frequency. The phase velocities are accessed from the object. Calculation of polarisation vectors (`getPolarisations()`) and strain tensor (`getStrain()`) follows the same principle. The functions `Intensity()` implementing equation 2.42 and `getPropagationMatrix()`

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implementing $\underline{P}_{=n}$ from equation 2.54 support the later mentioned methods from `Reflector`.

To construct a layer structure that can be evaluated by the simulation tools of `Reflector`, those `Layer` objects can be assembled in a list, which indicates the order of `Layers` in the reflector structure. Together with the defined thicknesses of each `Layer` object this forms an unambiguous representation of a physical layer structure.

This list of `Layer` objects is then passed to the constructor of a `Reflector` object and stored as deep copy of the initial list to avoid bugs through references to the same object. Besides, the layer thicknesses are extracted and stored internally in a separate list which is used exclusively over the object stored thicknesses. The first and the last given layer are assumed to embed the remaining layers, so that their thickness defined in the `Layer` object has no meaning. For convenience in the simulation functions, the thicknesses of first and last layer are set to 0 in `Reflector.__init__()`. The thickness configuration can be changed with `setThicknesses()` and a full text representation of the current configuration can be generated with `info()`.

3.1.1 Algorithms and their Scope of Application

There are four methods implemented to calculate the transmittivity function $\mathcal{T}_i(\omega, \theta)$ differing in numerical stability and speed. Those are `TransferMethod()` and `TransferMethodMP()`, which implement the Transfer Matrix Method. On the other side `LSEMethod()` and `SingleLSEMethod()` implement the described LSE method. To explain their coexistence, it is helpful to describe them in the order of their development.

The first attempt was `TransferMethod()`. The TMM offers the most promising properties with regard to computation time for large systems, because existing matrix multiplication algorithms as implemented in the `numpy` package can be used and the addition of layers to the problem only increases the computation time linearly. The latter becomes apparent when considering equation 2.57.

The concrete implementation is as follows. `TransferMethod()` called with arrays of circular frequencies ω , incident angles θ and the coefficient vector t_0 passes those parameters first to `getTotalTransfermatrix()`. This function calculates the \underline{S} matrix for the entire system as in equation 2.57. The function iterates in a python `for`-loop over all defined interfaces. In each iteration n , the transmitted angles from the previous interface $\theta_{n-1,i}$ are used as incident angles on the current interface n . Those are needed to calculate the wave vectors and the propagation

matrix $\underline{\underline{P}}_n$ with `getK()` and `getPropagationMatrix()` called on the upper Layer object. $\underline{\underline{S}}_n$ is also calculated from θ_n and ω with `TransferMatrix()`. Those two matrices, $\underline{\underline{S}}_n$ and $\underline{\underline{P}}_n$ are then multiplied to the evolving total S-matrix of the previous iteration $\underline{\underline{S}}'_{n-1}$ as

$$\underline{\underline{S}}'_n = \underline{\underline{S}}_{n-1} \quad (3.1)$$

concrete form
of condition
matrix im in
appendix

SIMULATIONS

CONCLUSION

BIBLIOGRAPHY

- ¹R. Gross and A. Marx, *Festkörperphysik* (De Gruyter Oldenbourg, 2014), pp. 143–155.
- ²T. Kundu, *Ultrasonic and electromagnetic nde for structure and material characterization: engineering and biomedical applications* (Taylor & Francis, 2012), pp. 27–30.
- ³A. Bedford and D. Drumheller, *Introduction to elastic wave propagation* (Jan. 1994), p. 43.
- ⁴J. Achenbach, N.-H. P. Company, and A. E. P. Company, *Wave propagation in elastic solids*, Applied Mathematics and Mechanics Series (North-Holland Publishing Company, 1973).
- ⁵L. Brekhovskikh, *Waves in layered media* (Elsevier Science, 2012).
- ⁶S. I. Fomenko, M. V. Golub, C. Zhang, T. Q. Bui, and Y. S. Wang, “In-plane elastic wave propagation and band-gaps in layered functionally graded phononic crystals”, *International Journal of Solids and Structures* **51**, 2491–2503 (2014).